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Analysis of Straw by X-ray Photoelectron Spectroscopy

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Determining the chemical structure and composition of biomass fuels using x-ray photoelectron spectroscopy (XPS) can provide fundamental knowledge of their structures that is useful in understanding and predicting their combustion behavior. Straw is an example of an agricultural residue (byproduct of food and feed production) of potential interest for biomass combustion. The XPS spectra of straw provide both its elemental composition and indications of its bonding. Traditional fuel analyses of this fuel are also provided. These include: ultimate analysis — the elemental composition of the overall fuel (C, H, N, S, and O); chlorine analysis — reported here as part of the ultimate analysis but formally a separate procedure; proximate analysis — the proximate composition of the fuel (moisture, fixed carbon, volatiles, and ash); heating value — the specific heat of combustion; ash chemistry analysis — an elemental analysis of the ash content, expressed as oxides (which does not imply that they occur as oxides in the fuel). These data are summarized with the XPS spectra. (© 2005 American Vacuum Society. [DOI: 10.1116/11.20040801]

Keywords: biomass; straw; XPS; fuel

PACS: 89.30-g, 82.80.Pv, 82.60.Cx

SPECIMEN DESCRIPTION

Host Material: straw

Host Material Characteristics: homogeneous; amorphous; unknown electrical characteristics; biological material; powder

Chemical Name: cellulose

Host Composition: see entry for History & Significance

Form: powder

History & Significance: Straw is an example of an agricultural residue (by product of food and feed production) of potential interest for biomass combustion. Agricultural residues came from 2002 harvests of straw and other agricultural materials in the U.S. and in Europe. The straw analyzed here is unusually low in alkali and chlorine compared to typical harvests.

The material under investigation underwent extensive homogenization and particle size classification to produce suitable feed materials for combustion tests that were later conducted. Straw comprises a mixture of cellulose, lignin, hemicellulose, extractives, proteins, inorganic material, and others.

The XPS spectra of straw provide both its elemental composition and indications of its bonding. Traditional fuel analyses of this fuel are also provided. These include: ultimate analysis — the elemental composition of the overall fuel (C, H, N, S, and O); chlorine analysis — reported here as part of the ultimate analysis but formally a separate procedure; proximate analysis — the proximate composition of the fuel (moisture, fixed carbon, volatiles, and ash); heating value — the specific heat of combustion; ash chemistry analysis — an elemental analysis of the ash content, expressed as oxides (which does not imply that they occur as oxides in the fuel). These data are summarized with the XPS spectra. The chemical composition of straw is summarized in Tables 1 and 2. Accession # 00895 Technique: XPS Host Material: straw Instrument: Surface Science Instruments SSX-100 Major Elements in Spectrum: C, O Minor Elements in Spectrum: N, Si Printed Spectra: 5 Spectra in Electronic Record: 5 Spectral Category: technical

Table 1: Fuel analysis of bio-fuel straw (ash free basis except for ash and LHV, which are on an as-received basis).

	% by weight
Moisture	10.23
С	40.83
Н	5.49
0	35.87
Ν	0.47
S	0.12
Ash	6.99
Sum	100
LHV*, MJ/kg	15.934

*Lower heating value

Table 2: Ash composition of straw (percent of ash	
basis).	

	Mass %
SiO ₂	52
Al_2O_3	0.6
Fe_2O_3	1.1
CaO	9.2
MgO	1.8
Na ₂ O	0.3
K ₂ O	21.9
SO ₃	4
P_2O_5	3.2
Cl	5.6
Other	0.3
Sum	100

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As Received Condition: powder

Analyzed Region: same as host material

Ex Situ Preparation/Mounting: Sawdust powders were used as received. The powders were pressed onto a piece of nonconductive double-sticky tape mounted on a piece of silicon, which was then mounted on the sample stage with a piece of the same tape.

In Situ Preparation: not specified

- **Pre-Analysis Beam Exposure:** No damage was observed in the sample even after several hours of exposure to x-ray radiation. After 4 h of exposure to x rays, the intensity of the N 1*s* scan did not change.
- **Charge Control:** A flood gun was applied. The flood gun voltage was 4 V, and its current was less than 50 mA. A metal screen was used to mask the sample. The charge control was determined by observing zirconia Zr $3p_{3/2}$ peak positions under different flood gun settings. XPS spectra showed a Zr $3d_{5/2}$ at 182.3 eV. The metal screen used was nickel, 1 mm distance, 70 lines/in. and 90% transmission.

Temp. During Analysis: 298 K

Pressure During Analysis: $<2.0\times10^{-6}$ Pa

INSTRUMENT DESCRIPTION -

Manufacturer and Model: Surface Science Instruments SSX-100

Analyzer Type: spherical sector

Detector: resistive anode position detector

Number of Detector Elements: 128

INSTRUMENT PARAMETERS COMMON TO ALL SPECTRA

Spectrometer

Analyzer Mode: constant pass energy

Throughput ($T = E^N$): N = 0Excitation Source Window: 12 µm

Excitation Source Window: 12 μ m aluminum foil **Excitation Source:** Al K_{α} monochromatic **Source Energy:** 1486.6 eV **Source Strength:** 200 W **Signal Mode:** multichannel direct

■ Geometry

Incident Angle: 55° Source to Analyzer Angle: 70.8° Emission Angle: 55° Specimen Azimuthal Angle: 0° Acceptance Angle from Analyzer Axis: 0°

DATA ANALYSIS METHOD -

- Peak Shape and Background Method: Shirley background function
- **Quantitation Method:** Sensitivity factors were obtained from ESCA 2000 NT software supplied by Service Physics. The peak areas are the areas above a linear background.

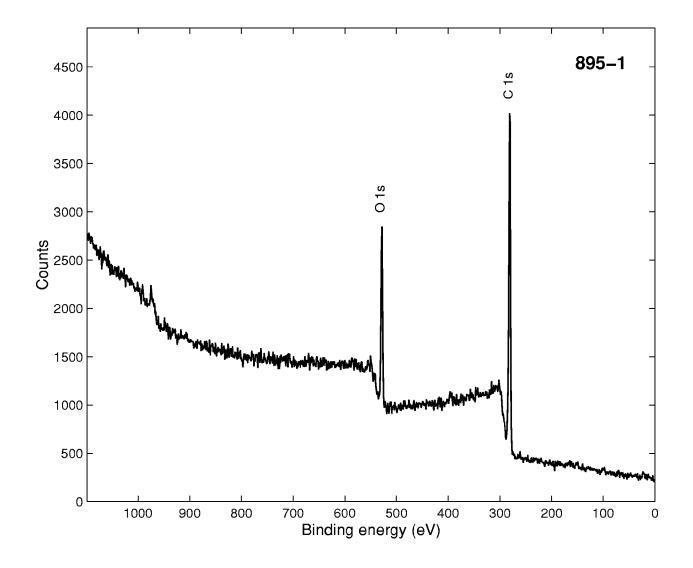
ACKNOWLEDGMENTS -

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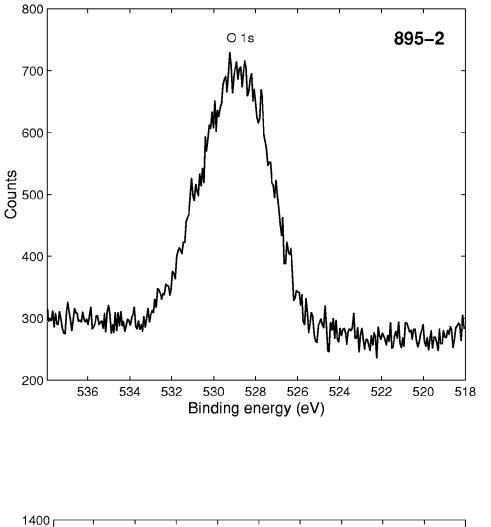
	SPECTRAL FEATURES TABLE						
Spectrum ID #	Element/ Transition	Peak Energy (eV)	Peak Width FWHM (eV)	Peak Area (counts)	Sensitivity Factor	Concen- tration (at. %)	Peak Assignment
00895-02	O 1 <i>s</i>	527.7	1.5	27900	2.5	16.1	•••
00895-03	C 1 <i>s</i>	280.2	1.3	57700	1	83.0	
00895-04	N 1 <i>s</i>	396.6	5.0	50500	1.68	0.9	
00895-05	Si 2p	99.3	3.6	3690	0.9		

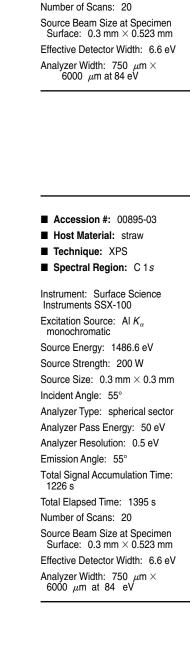
GUIDE TO FIGURES					
Spectrum (Accession) #	Spectral Region	Voltage Shift*	Multiplier	Baseline	Comment #
895-1	Survey	0	1	0	1
895-2	O 1 <i>s</i>	0	1	0	2
895-3	C 1 <i>s</i>	0	1	0	2
895-4	N 1 <i>s</i>	0	1	0	2
895-5	Si 2p	0	1	0	1

* Voltage shift of the archived (as-measured) spectrum relative to the printed figure. The figure reflects the recommended energy scale correction due to a calibration correction, sample charging, flood gun, or other phenomenon.
1. 800 μm x-ray beam diameter, 150 eV pass energy
2. 300 μm x-ray beam diameter, 50 eV pass energy



Accession #	00895-01	
Host Material	straw	
Technique	XPS	
Spectral Region	survey	
Instrument	Surface Science Instruments SSX-100	
Excitation Source	Al K_{α} monochromatic	
Source Energy	1486.6 eV	
Source Strength	200 W	
Source Size	0.8 mm \times 0.8 mm	
Analyzer Type	spherical sector	
Incident Angle	55°	
Emission Angle	55°	
Analyzer Pass Energy	150 eV	
Analyzer Resolution	1.5 eV	
Total Signal Accumulation Time	2200 s	
Total Elapsed Time	2400 s	
Number of Scans	10	
Source Beam Size at Specimen Surface	$0.8 \text{ mm} \times 1.392 \text{ mm}$	
Effective Detector Width	19 eV	
Analyzer Width	1500 μ m \times 12000 μ m at 84 eV	





■ Accession #: 00895-02

Host Material: straw

■ Spectral Region: 01s

Instrument: Surface Science Instruments SSX-100 Excitation Source: Al K_{α}

Source Size: $0.3 \text{ mm} \times 0.3 \text{ mm}$

Analyzer Type: spherical sector Analyzer Pass Energy: 50 eV Analyzer Resolution: 0.5 eV

Total Signal Accumulation Time:

Total Elapsed Time: 1395 s

Technique: XPS

monochromatic Source Energy: 1486.6 eV Source Strength: 200 W

Incident Angle: 55°

Emission Angle: 55°

1226 s

